# Notice of References Cited

Application/Control No.

10/075,640

Examiner

DAVID VU

Applicant(s)/Patent Under Reexamination NUTTALL ET AL.

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### **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,854,105	12-1998	Tseng, Horng-Huei	438/253
	В	US-5,766,994	06-1998	Tseng, Horng-Huei	438/254
	С	US-6,137,130	10-2000	Sung, Janmye	257/306
	D	US-6,130,102	10-2000	White et al.	438/3
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

#### **FOREIGN PATENT DOCUMENTS**

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	N					
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## **NON-PATENT DOCUMENTS**

	TOTAL						
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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	V						
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	x						

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